Docket: 0756-7224

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

| n re DIVISIONAL application of |) | |
|-----------------------------------|---|----------------------|
| HONGYONG ZHANG et al. |) | |
| Based on Serial No. 09/356,376 |) | Group Art Unit: 2871 |
| Filed: July 19, 1999 |) | Examiner: K. Parker |
| For: PROCESS FOR LASER PROCESSING |) | |
| AND APPARATUS FOR USE IN THE |) | |
| SAME |) | |

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56 and 37 C.F.R. 1.97-1.99, Applicant submits herewith a Form PTO-1449 listing references known to Applicant and requests that these references be made of record in the above identified application. Copies of the references listed are submitted herewith in accordance with 37 C.F.R. 1.98(a).

The Examiner's attention is directed to U.S. Patent 4,859,908, which is listed on the PTO Form 1449 attached herewith for the Examiner's consideration.

Japanese Patent Laid-Open No. 50-117374 was cited by the Japanese Patent Office as it teaches to dope an insulating film with an impurity.

Japanese Patent Laid-Open No. 64-011323 teaches the use of a pulsed laser beam for introducing an impurity. This reference discusses the number of pulses and the damage to the semiconductor surface. Fig. 3 shows a relation between the number of laser pulses relative to the unevenness of a surface (nm).

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The references listed on the attached Form PTO-1449 were cited in parent application Serial No. 09/356,376 and predecessor Application Serial Nos. 09/145,543; 08/411,973 and 07/971,237 and copies of the references can be found in those applications.

Respectfully submitted,

Eric J. Robinson

Reg. No. 38,285

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| INFO | RMATION I |)ICC | Aditso | Application Number | Based on 09/356,376 | |
| 1 | | | | Filing Date | July 19, 1999 | |
| SIA | TEMENT BY | | | First Named Inventor | Hongyong ZHANG et al. | |
| | (use as many sheets o | as necesso | ary) | Group Art Unit | 2871 | |
| | | | | Examiner Name | Kenneth Parker | |
| Sheet | 1 | of | 3 | Attorney Docket Number | 0756-7224 | |

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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| Sheet | 2 | of | 3 | Attorney Docket Number | 0756-7224 | |

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| | | | | Examiner Name | Kenneth Parker | |
| Sheet | 3 | of | 3 | Attorney Docket Number | 0756-7224 | |

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